

## **TSG15N120**

### **IGBT trench process**

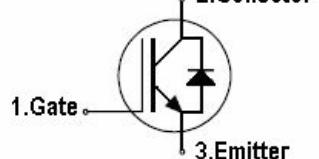
#### **Features**

- ◆ 1200V,15A
- ◆ VCE(sat)(typ.)=2.4V@VGE=15V, IC=15A
- ◆ High speed switching
- ◆ Higher system efficiency
- ◆ built-in FRD

#### **General Description**

- ◆ Package:TO-247
- ◆ TS IGBTs with trench process offer lower losses and higher energy efficiency for application such as IH (induction heating),UPS, general inverter and other soft switching applications.

#### **DRAWING**



#### **Absolute Maximum Ratings**

Symbol	Parameter		Spec	Units
$V_{CES}$	Collector-Emitter Voltage		1200	V
$V_{GES}$	Gate-Emitter Voltage		$\pm 20$	V
$I_C$	Continuous Collector Current	( TC=25 °C )	30	A
	Continuous Collector Current	( TC=100°C )	15	
$I_{CM}$	Pulsed Collector Current (Note 1)		45	A
$I_F$	Diode Continuous Forward Current	( TC=25 °C )	30	A
	Diode Continuous Forward Current	( TC=100°C )	15	
$I_{FM}$	Diode Maximum Forward Current (Note 1)		45	A
$t_{sc}$	Short Circuit Withstand Time		10	us
$P_D$	Maximum Power Dissipation	( TC=25 °C )	208	W
	Maximum Power Dissipation	( TC=100°C )	83	W
$T_J$	Operating Junction Temperature Range		-55 to +150	°C
$T_{STG}$	Storage Temperature Range		-55 to +150	°C

**Note1:** Repetitive Rating: Pulse width limited by maximum junction temperature

#### **Thermal Characteristics**

Symbol	Parameter	Spec	Units
$R_{th j-c}$	Thermal Resistance, Junction to case for IGBT	0.6	KW
$R_{th j-c}$	Thermal Resistance, Junction to case for Diode	2	
$R_{th j-a}$	Thermal Resistance, Junction to Ambient	40	

**Electrical Characteristics (TC=25°C unless otherwise noted )**

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
<b>Static characteristics</b>						
BV <sub>CES</sub>	Collector-Emitter Breakdown Voltage	VGE= 0V, IC= 250uA	1200			V
I <sub>CES</sub>	Collector-Emitter Leakage Current	VCE= 1200V, VGE= 0V	T <sub>j</sub> =25 °C		0.1	mA
			T <sub>j</sub> =150 °C		2.0	
I <sub>GES</sub>	Gate Leakage Current, Forward	VGE=20V, VCE= 0V			100	nA
	Gate Leakage Current, Reverse	VGE= -20V, VCE= 0V			-100	nA
V <sub>GE(th)</sub>	Gate Threshold Voltage	VGE= VCE, IC= 250uA	5.0	5.8	6.5	V
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage	VGE=15V, IC= 15A	T <sub>j</sub> =25 °C	2.4	2.7	V
			T <sub>j</sub> =150 °C	2.85		
V <sub>F</sub>	Diode Forward Voltage	VGE= 0V, IF=15A	T <sub>j</sub> =25 °C	1.2		V
			T <sub>j</sub> =150 °C	1.15		
g <sub>FS</sub>	transconductance	VCE= 20V, IC= 15A		4.5		S
<b>Dynamic characteristics</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>CE</sub> =25V V <sub>GE</sub> =0V f = 1MHz		1678		pF
C <sub>oss</sub>	Output Capacitance			57		
C <sub>rss</sub>	Reverse Transfer Capacitance			27		
Q <sub>G</sub>	Gate Charge	V <sub>CC</sub> =900V, IC=15A, V <sub>GE</sub> =15V		64		nc
<b>IGBT switching characteristic(Inductive Load)</b>						
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>CC</sub> =600V I <sub>C</sub> =15A V <sub>GE</sub> =15V/0V R <sub>G</sub> =15 Ω L <sub>Load</sub> =500 μ H T <sub>C</sub> =25 °C		23		ns
t <sub>r</sub>	Turn-on Rise Time			41		
t <sub>d(off)</sub>	Turn-off Delay Time			95		
t <sub>f</sub>	Turn-off Fall Time			103		
E <sub>on</sub>	Turn-on Switching Loss			0.75		mJ
E <sub>off</sub>	Turn-off Switching Loss			0.38		
E <sub>ts</sub>	Total Switching Loss			1.12		
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>CC</sub> =600V V <sub>GE</sub> =15V/0V I <sub>C</sub> =15A R <sub>G</sub> =15 Ω L <sub>Load</sub> =500 μ H T <sub>C</sub> =150 °C		18		ns
t <sub>r</sub>	Turn-on Rise Time			25		
t <sub>d(off)</sub>	Turn-off Delay Time			123		
t <sub>f</sub>	Turn-off Fall Time			238		
E <sub>on</sub>	Turn-on Switching Loss			0.73		mJ
E <sub>off</sub>	Turn-off Switching Loss			0.77		
E <sub>ts</sub>	Total Switching Loss			1.50		

Typical Characteristics

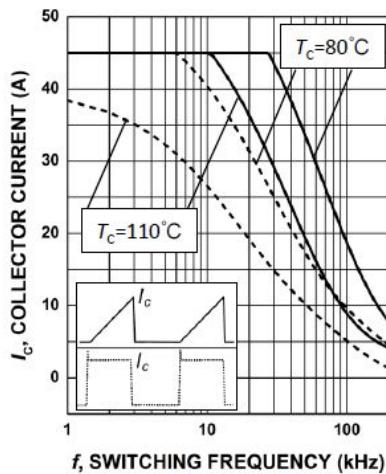


Figure 1. Collector current as a function of switching frequency  
 $(T_j \leq 150^\circ\text{C}, D = 0.5, V_{CE} = 600\text{V}, V_{GE} = 0/+15\text{V}, R_G = 15\Omega)$

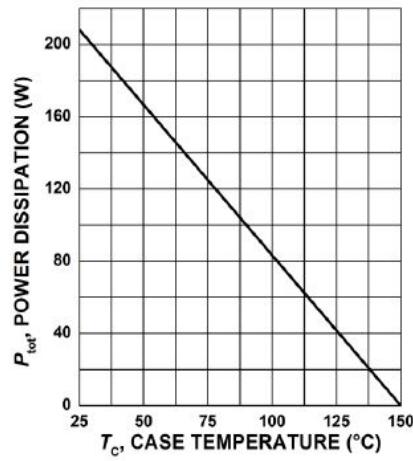


Figure 2. Maximum power dissipation as a function of case temperature  
 $(T_j \leq 150^\circ\text{C})$

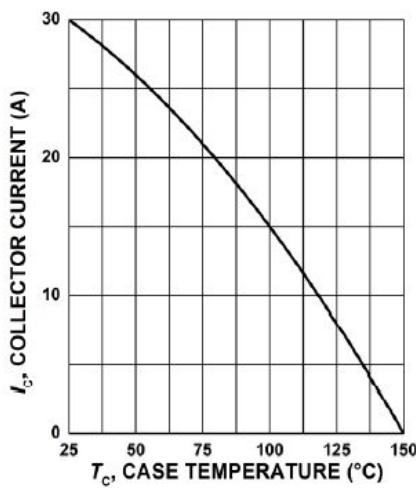


Figure 3. Maximum collector current as a function of case temperature  
 $(V_{GE} \geq 15\text{V}, T_j \leq 150^\circ\text{C})$

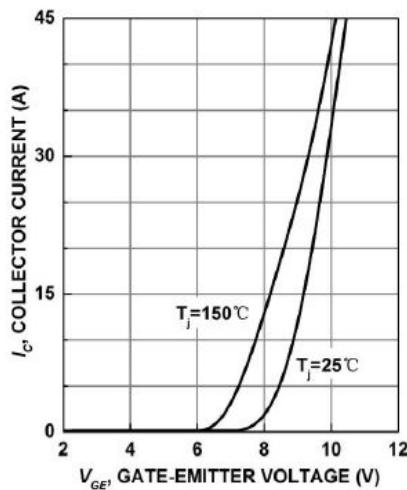


Figure 4. Typical transfer characteristic  
 $(V_{CE}=15\text{V})$

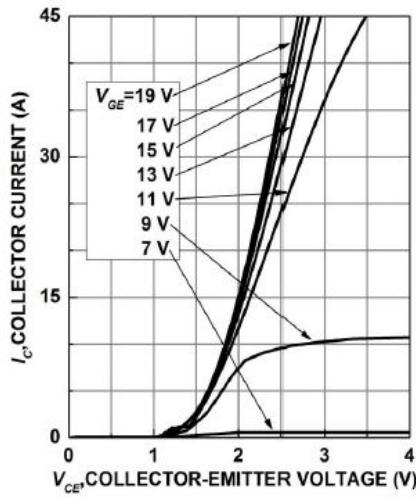


Figure 5. Typical output characteristic  
( $T_j = 25^\circ\text{C}$ )

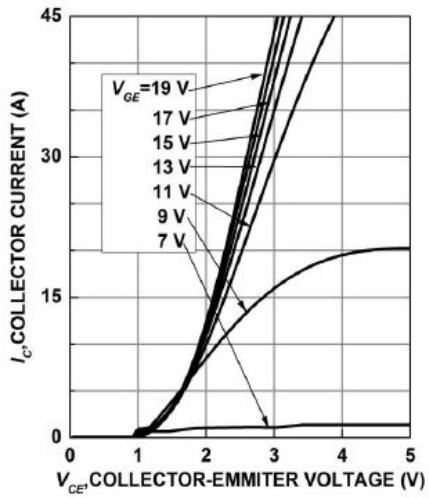


Figure 6. Typical output characteristic  
( $T_j = 150^\circ\text{C}$ )

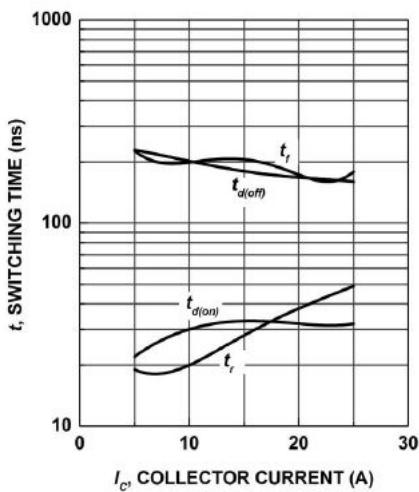


Figure 7. Typical switching times as a function of collector current  
(inductive load,  $T_j=150^\circ\text{C}$ ,  $V_{CE}=600\text{V}$ ,  
 $V_{GE}=0/15\text{V}$ ,  $R_G=15\Omega$ ,  
Dynamic test circuit in Figure D)

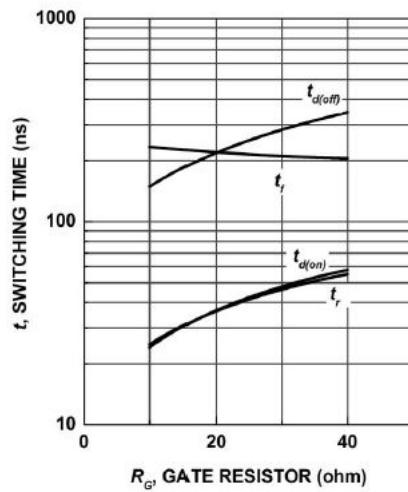


Figure 8. Typical switching times as a function of gate resistor  
(inductive load,  $T_j=150^\circ\text{C}$ ,  $V_{CE}=600\text{V}$ ,  
 $V_{GE}=0/15\text{V}$ ,  $I_c=15\text{A}$ , Dynamic test circuit in  
Figure D)

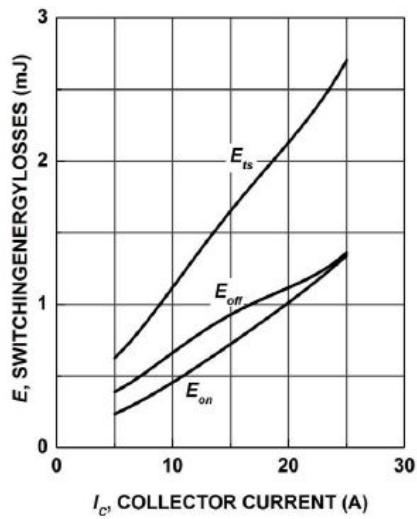


Figure 9. Typical switching energy losses as a function of collector current  
(inductive load,  $T_j=150^\circ\text{C}$ ,  $V_{CE}=600\text{V}$ ,  
 $V_{GE}=0/15\text{V}$ ,  $R_G=15\Omega$ ,  
Dynamic test circuit in Figure D)

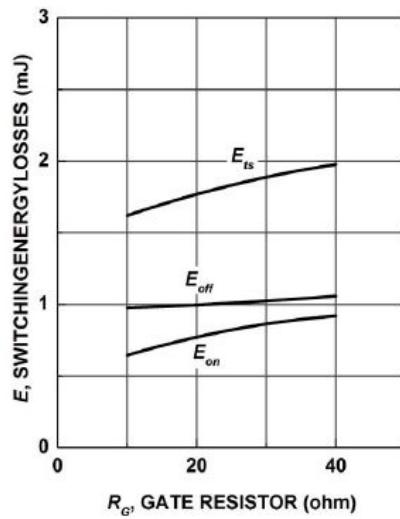


Figure 10. Typical switching energy losses as a function of gate resistor  
(inductive load,  $T_j=150^\circ\text{C}$ ,  $V_{CE}=600\text{V}$ ,  
 $V_{GE}=0/15\text{V}$ ,  $I_C=15\text{A}$ ,  
Dynamic test circuit in Figure D)

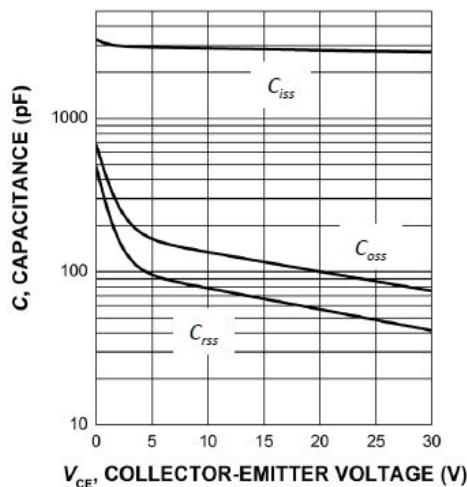


Figure 11. Typical capacitance as a function of collector-emitter voltage  
( $V_{GE}=0\text{V}$ ,  $f = 1 \text{ MHz}$ )

Test circuits and waveforms

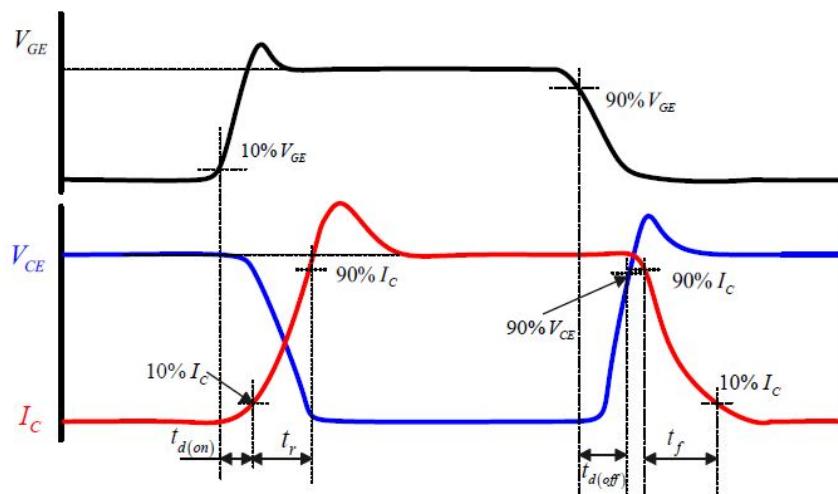


Figure A. Definition of switching times

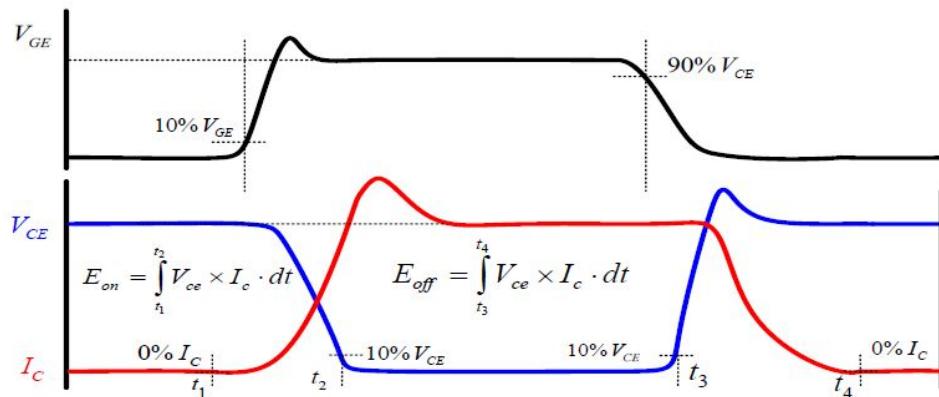


Figure B. Definition of switching losses

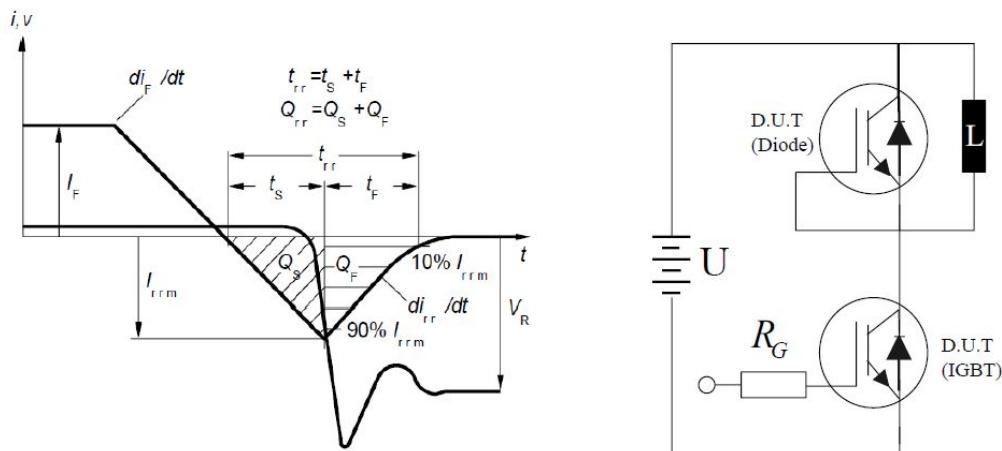


Figure C. Definition of diodes switching characteristics

Figure D. Dynamic test circuit

**Mechanical Dimensions**

